74LVC1G17

Single Schmitt trigger buffer

Product data sheet

1. General description

The 74LVC1G17 provides a buffer function with Schmitt trigger input. It is capable of transforming slowly changing input signals into sharply defined outputs.

The input can be driven from either 3.3 V or 5 V devices. This feature allows the use of this device in a mixed 3.3 V and 5 V environment.

This device is fully specified for partial power-down applications using I_{OFF}. The I_{OFF} circuitry disables the output, preventing the damaging backflow current through the device when it is powered down.

2. Features and benefits

- Wide supply voltage range from 1.65 V to 5.5 V
- High noise immunity
- Complies with JEDEC standard
  - JESD8-7 (1.65 V to 1.95 V)
  - JESD8-5 (2.3 V to 2.7 V)
  - JESD8B/JESD36 (2.7 V to 3.6 V)
- ESD protection:
  - HBM JESD22-A114F exceeds 2 000 V
  - MM JESD22-A115-A exceeds 200 V
- ±24 mA output drive ($V_{CC} = 3.0$ V)
- CMOS low power consumption
- Latch-up performance exceeds 250 mA
- Direct interface with TTL levels
- Unlimited rise and fall times
- Inputs accept voltages up to 5 V
- Multiple package options
- Specified from -40 °C to $+85$ °C and from -40 °C to $+125$ °C

3. Ordering information

Table 1. Ordering information

Type number	Package				Version
	Temperature range	**Name**	**Description**		
74LVC1G17GW	−40 °C to +125 °C	TSSOP5	plastic thin shrink small outline package; 5 leads; body width 1.25 mm		SOT353-1
74LVC1G17GV	−40 °C to +125 °C	SC-74A	plastic surface-mounted package; 5 leads		SOT753
74LVC1G17GM	−40 °C to +125 °C	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1 × 1.45 × 0.5 mm		SOT886
74LVC1G17GF	−40 °C to +125 °C	XSON6	plastic extremely thin small outline package; no leads; 6 terminals; body 1 × 1 × 0.5 mm		SOT891
74LVC1G17GN	−40 °C to +125 °C	XSON6	extremely thin small outline package; no leads; 6 terminals; body 0.9 × 1.0 × 0.35 mm		SOT1115
74LVC1G17GS	−40 °C to +125 °C	XSON6	extremely thin small outline package; no leads; 6 terminals; body 1.0 × 1.0 × 0.35 mm		SOT1202
74LVC1G17GX	−40 °C to +125 °C	X2SON5	X2SON5: plastic thermal enhanced extremely thin small outline package; no leads; 5 terminals; body 0.8 × 0.8 × 0.35 mm		SOT1226

4. Marking

Table 2. Marking codes

Type number	Marking[1]
74LVC1G17GW	VJ
74LVC1G17GV	V17
74LVC1G17GM	VJ
74LVC1G17GF	VJ
74LVC1G17GN	VJ
74LVC1G17GS	VJ
74LVC1G17GX	VJ

[1] The pin 1 indicator is located on the lower left corner of the device, below the marking code.
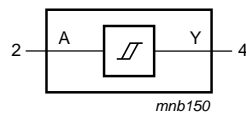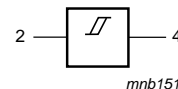
5. Functional diagram

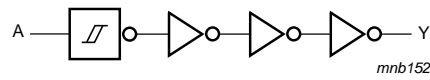**Fig 1. Logic symbol**

mnb150

Fig 2. IEC logic symbol

mnb151

Fig 3.   Logic diagram

6.   Pinning information

6.1   Pinning
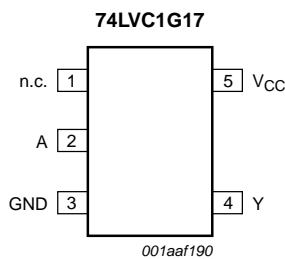
Fig 4.   Pin configuration SOT353-1 and SOT753

Transparent top view
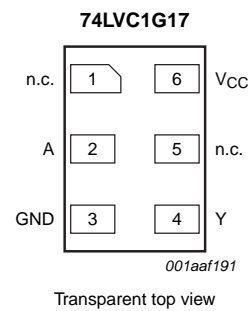
Fig 5.   Pin configuration SOT886

Transparent top view
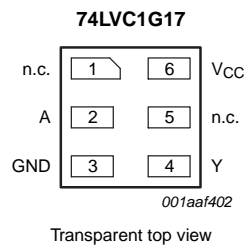
Fig 6.   Pin configuration SOT891, SOT1115 and SOT1202

Transparent top view
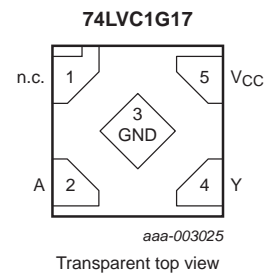
Fig 7.   Pin configuration SOT1226 (X2SON5)

6.2   Pin description

Table 3.   Pin description

Symbol	Pin		Description
	TSSOP5 and X2SON5	**XSON6**	
n.c.	1	1, 5	not connected
A	2	2	data input
GND	3	3	ground (0 V)
Y	4	4	data output
V_{CC}	5	6	supply voltage

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7. Functional description

Table 4.   Function table[1]

Input	Output
A	**Y**
L	L
H	H

[1]   H = HIGH voltage level; L = LOW voltage level

8. Limiting values

Table 5.   Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{CC}	supply voltage			−0.5	+6.5	V
I_{IK}	input clamping current	$V_I < 0$ V		−50	-	mA
V_I	input voltage		[1]	−0.5	+6.5	V
I_{OK}	output clamping current	$V_O > V_{CC}$ or $V_O < 0$ V		-	±50	mA
V_O	output voltage	Active mode	[1][2]	−0.5	V_{CC} + 0.5	V
		Power-down mode	[1][2]	−0.5	+6.5	V
I_O	output current	$V_O = 0$ V to V_{CC}		-	±50	mA
I_{CC}	supply current			-	100	mA
I_{GND}	ground current			−100	-	mA
P_{tot}	total power dissipation	$T_{amb} = $ −40 °C to +125 °C	[3]	-	250	mW
T_{stg}	storage temperature			−65	+150	°C

[1]   The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2]   When $V_{CC} = 0$ V (Power-down mode), the output voltage can be 5.5 V in normal operation.

[3]   For TSSOP5 and SC-74A packages: above 87.5 °C the value of P_{tot} derates linearly with 4.0 mW/K.
        For XSON6 and X2SON5 package: above 118 °C the value of P_{tot} derates linearly with 7.8 mW/K.

9. Recommended operating conditions

Table 6.   Recommended operating conditions

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{CC}	supply voltage		1.65	-	5.5	V
V_I	input voltage		0	-	5.5	V
V_O	output voltage	Active mode	0	-	V_{CC}	V
		$V_{CC} = 0$ V; Power-down mode	0	-	5.5	V
T_{amb}	ambient temperature		−40	-	+125	°C

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10. Static characteristics

Table 7.   Static characteristics

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
T_{amb} = −40 °C to +85 °C						
V_{OH}	HIGH-level output voltage	$V_I = V_{T+}$ or $V_{T−}$				
		$I_O = −100$ µA; $V_{CC} = 1.65$ V to 5.5 V	$V_{CC} − 0.1$	-	-	V
		$I_O = −4$ mA; $V_{CC} = 1.65$ V	1.2	-	-	V
		$I_O = −8$ mA; $V_{CC} = 2.3$ V	1.9	-	-	V
		$I_O = −12$ mA; $V_{CC} = 2.7$ V	2.2	-	-	V
		$I_O = −24$ mA; $V_{CC} = 3.0$ V	2.3	-	-	V
		$I_O = −32$ mA; $V_{CC} = 4.5$ V	3.8	-	-	V
V_{OL}	LOW-level output voltage	$V_I = V_{T+}$ or $V_{T−}$				
		$I_O = 100$ µA; $V_{CC} = 1.65$ V to 5.5 V	-	-	0.1	V
		$I_O = 4$ mA; $V_{CC} = 1.65$ V	-	-	0.45	V
		$I_O = 8$ mA; $V_{CC} = 2.3$ V	-	-	0.3	V
		$I_O = 12$ mA; $V_{CC} = 2.7$ V	-	-	0.4	V
		$I_O = 24$ mA; $V_{CC} = 3.0$ V	-	-	0.55	V
		$I_O = 32$ mA; $V_{CC} = 4.5$ V	-	-	0.55	V
I_I	input leakage current	$V_I = 5.5$ V or GND; $V_{CC} = 0$ V to 5.5 V	-	±0.1	±5	µA
I_{OFF}	power-off leakage current	V_I or $V_O = 5.5$ V; $V_{CC} = 0$ V	-	±0.1	±10	µA
I_{CC}	supply current	$V_I = 5.5$ V or GND; $V_{CC} = 1.65$ V to 5.5 V; $I_O = 0$ A	-	0.1	10	µA
ΔI_{CC}	additional supply current	$V_I = V_{CC} − 0.6$ V; $I_O = 0$ A; $V_{CC} = 2.3$ V to 5.5 V; per pin	-	5	500	µA
C_I	input capacitance		-	5	-	pF
T_{amb} = −40 °C to +125 °C						
V_{OH}	HIGH-level output voltage	$V_I = V_{T+}$ or $V_{T−}$				
		$I_O = −100$ µA; $V_{CC} = 1.65$ V to 5.5 V	$V_{CC} − 0.1$	-	-	V
		$I_O = −4$ mA; $V_{CC} = 1.65$ V	0.95	-	-	V
		$I_O = −8$ mA; $V_{CC} = 2.3$ V	1.7	-	-	V
		$I_O = −12$ mA; $V_{CC} = 2.7$ V	1.9	-	-	V
		$I_O = −24$ mA; $V_{CC} = 3.0$ V	2.0	-	-	V
		$I_O = −32$ mA; $V_{CC} = 4.5$ V	3.4	-	-	V
V_{OL}	LOW-level output voltage	$V_I = V_{T+}$ or $V_{T−}$				
		$I_O = 100$ µA; $V_{CC} = 1.65$ V to 5.5 V	-	-	0.1	V
		$I_O = 4$ mA; $V_{CC} = 1.65$ V	-	-	0.7	V
		$I_O = 8$ mA; $V_{CC} = 2.3$ V	-	-	0.45	V
		$I_O = 12$ mA; $V_{CC} = 2.7$ V	-	-	0.6	V
		$I_O = 24$ mA; $V_{CC} = 3.0$ V	-	-	0.80	V
		$I_O = 32$ mA; $V_{CC} = 4.5$ V	-	-	0.80	V
I_I	input leakage current	$V_I = 5.5$ V or GND; $V_{CC} = 0$ V to 5.5 V	-	-	±100	µA

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Table 7.   Static characteristics *…continued*

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

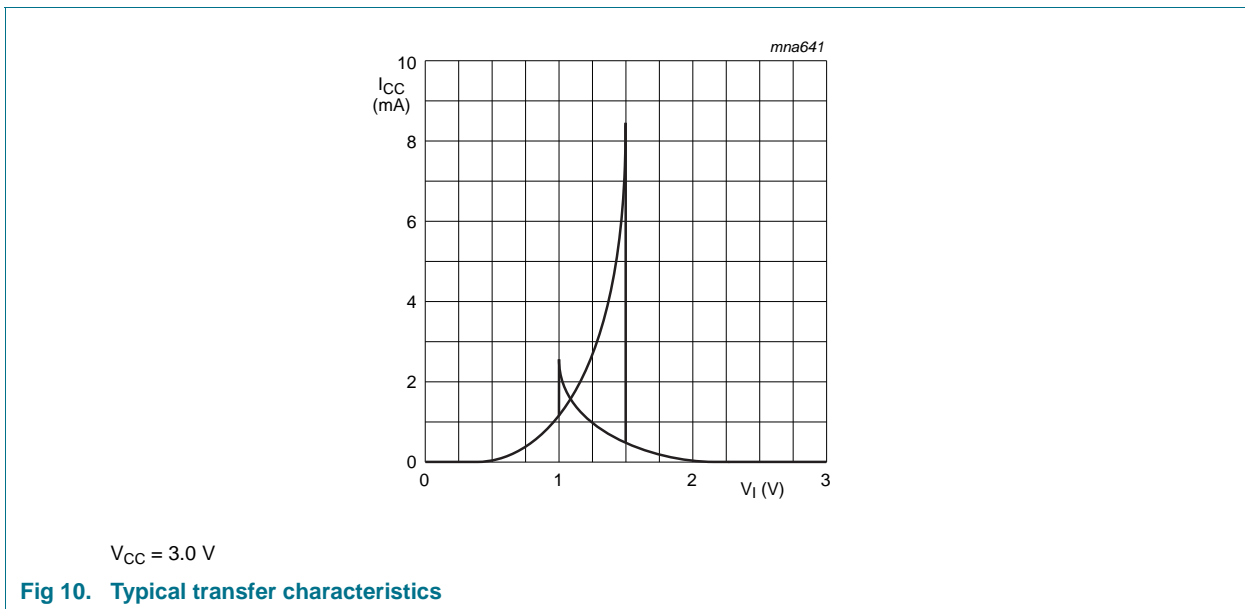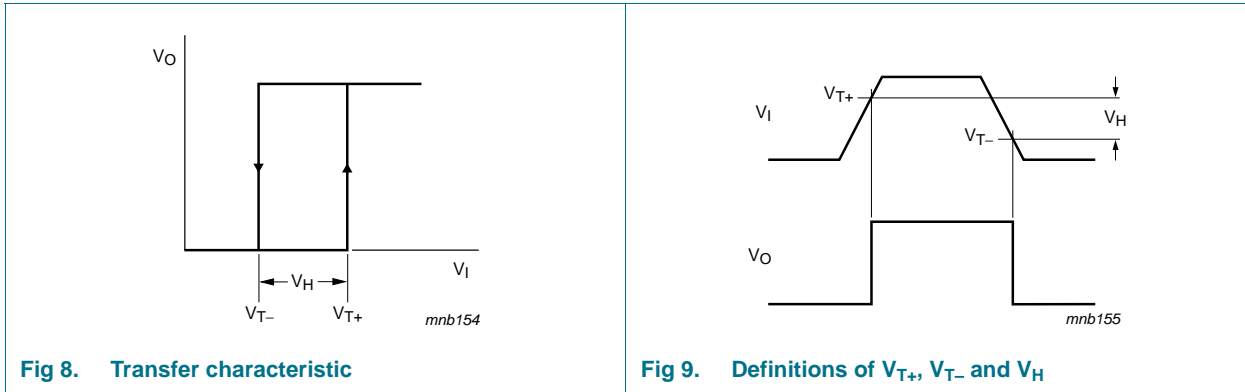| Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
I_{OFF}	power-off leakage current	V_I or V_O = 5.5 V; V_{CC} = 0 V	-	-	±200	μA
I_{CC}	supply current	V_I = 5.5 V or GND; V_{CC} = 1.65 V to 5.5 V; I_O = 0 A	-	-	200	μA
ΔI_{CC}	additional supply current	per pin; $V_I = V_{CC} - 0.6$ V; I_O = 0 A; V_{CC} = 2.3 V to 5.5 V	-	-	5000	μA

[1]   All typical values are measured at maximum V_{CC} and T_{amb} = 25 °C.

Table 8.   Transfer characteristics

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	−40 °C to +85 °C			−40 °C to +125 °C		Unit
			Min	Typ[1]	Max	Min	Max	
V_{T+}	positive-going threshold voltage	see Figure 8 and Figure 9						
		V_{CC} = 1.8 V	0.82	1.0	1.14	0.79	1.14	V
		V_{CC} = 2.3 V	1.03	1.2	1.40	1.00	1.40	V
		V_{CC} = 3.0 V	1.29	1.5	1.71	1.26	1.71	V
		V_{CC} = 4.5 V	1.84	2.1	2.36	1.81	2.36	V
		V_{CC} = 5.5 V	2.19	2.5	2.79	2.16	2.79	V
V_{T-}	negative-going threshold voltage	see Figure 8 and Figure 9						
		V_{CC} = 1.8 V	0.46	0.6	0.75	0.46	0.78	V
		V_{CC} = 2.3 V	0.65	0.8	0.96	0.65	0.99	V
		V_{CC} = 3.0 V	0.88	1.0	1.24	0.88	1.27	V
		V_{CC} = 4.5 V	1.32	1.5	1.84	1.32	1.87	V
		V_{CC} = 5.5 V	1.58	1.8	2.24	1.58	2.27	V
V_H	hysteresis voltage	see Figure 8, Figure 9 and Figure 10						
		V_{CC} = 1.8 V	0.26	0.4	0.51	0.19	0.51	V
		V_{CC} = 2.3 V	0.28	0.4	0.57	0.22	0.57	V
		V_{CC} = 3.0 V	0.31	0.5	0.64	0.25	0.64	V
		V_{CC} = 4.5 V	0.40	0.6	0.77	0.34	0.77	V
		V_{CC} = 5.5 V	0.47	0.6	0.88	0.41	0.88	V

[1]   All typical values are measured at T_{amb} = 25 °C.

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10.1 Transfer characteristic waveforms

Fig 8.   Transfer characteristic

Fig 9.   Definitions of V_{T+}, V_{T-} and V_H

$V_{CC} = 3.0$ V

Fig 10. Typical transfer characteristics

11. Dynamic characteristics

Table 9.   Dynamic characteristics

Voltages are referenced to GND (ground = 0 V). For test circuit see Figure 12.

Symbol	Parameter	Conditions		−40 °C to +85 °C			−40 °C to +125 °C		Unit
				Min	Typ[1]	Max	Min	Max	
t_{pd}	propagation delay	A to Y; see Figure 11	[2]						
		V_{CC} = 1.65 V to 1.95 V		1.0	4.1	11.0	1.0	14.0	ns
		V_{CC} = 2.3 V to 2.7 V		0.7	2.8	6.5	0.7	8.5	ns
		V_{CC} = 2.7 V		0.7	3.2	6.5	0.7	8.5	ns
		V_{CC} = 3.0 V to 3.6 V		0.7	3.0	5.5	0.7	7.0	ns
		V_{CC} = 4.5 V to 5.5 V		0.7	2.2	5.0	0.7	6.5	ns
C_{PD}	power dissipation capacitance	V_I = GND to V_{CC}; V_{CC} = 3.3 V	[3]	-	16.6	-	-	-	pF

[1]   Typical values are measured at T_{amb} = 25 °C and V_{CC} = 1.8 V, 2.5 V, 2.7 V, 3.3 V and 5.0 V respectively.

[2] t_{pd} is the same as t_{PLH} and t_{PHL}.

[3] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma(C_L \times V_{CC}^2 \times f_o)$ where:

f_i = input frequency in MHz;

f_o = output frequency in MHz;

C_L = output load capacitance in pF;

V_{CC} = supply voltage in V;

N = number of inputs switching;

$\Sigma(C_L \times V_{CC}^2 \times f_o)$ = sum of outputs.

12. Waveforms

Measurement points are given in Table 10.

V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

Fig 11.   The input A to output Y propagation delay times
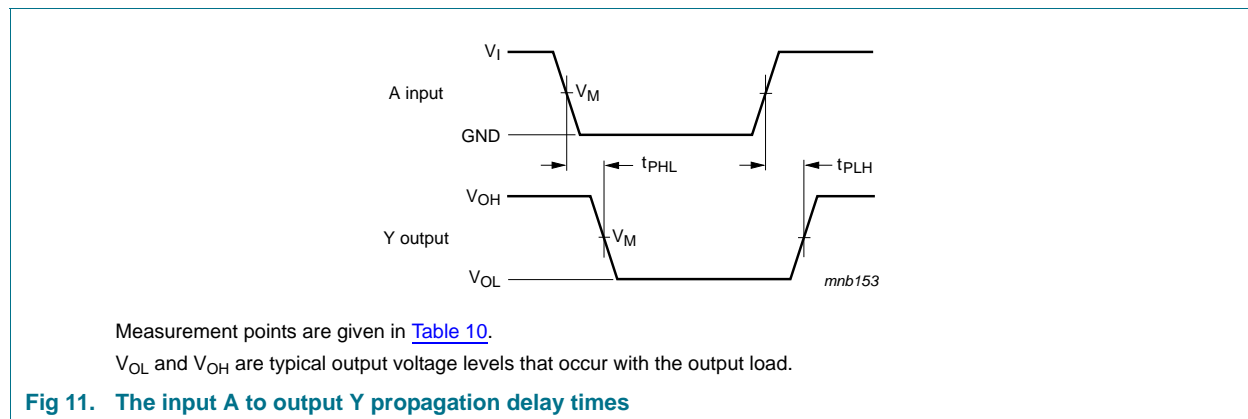
Table 10.   Measurement points

Supply voltage	Input	Output
V_{CC}	V_M	V_M
1.65 V to 1.95 V	0.5 × V_{CC}	0.5 × V_{CC}
2.3 V to 2.7 V	0.5 × V_{CC}	0.5 × V_{CC}

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Table 10.   Measurement points *…continued*

Supply voltage	Input	Output
V_{CC}	V_M	V_M
2.7 V	1.5 V	1.5 V
3.0 V to 3.6 V	1.5 V	1.5 V
4.5 V to 5.5 V	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$
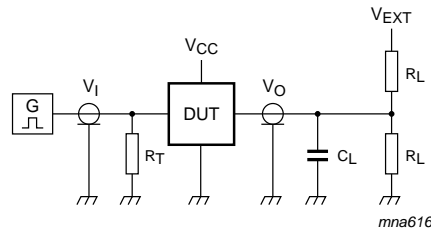
Test data is given in Table 11.

Definitions for test circuit:

R_L = Load resistance.

C_L = Load capacitance including jig and probe capacitance.

R_T = Termination resistance should be equal to the output impedance Z_o of the pulse generator.

V_{EXT} = External voltage for measuring switching times.

Fig 12. Test circuit for measuring switching times

Table 11.   Test data

Supply voltage	Input		Load		V_{EXT}
V_{CC}	V_I	$t_r = t_f$	C_L	R_L	t_{PLH}, t_{PHL}
1.65 V to 1.95 V	V_{CC}	$\leq$ 2.0 ns	30 pF	1 kΩ	open
2.3 V to 2.7 V	V_{CC}	$\leq$ 2.0 ns	30 pF	500 Ω	open
2.7 V	2.7 V	$\leq$ 2.5 ns	50 pF	500 Ω	open
3.0 V to 3.6 V	2.7 V	$\leq$ 2.5 ns	50 pF	500 Ω	open
4.5 V to 5.5 V	V_{CC}	$\leq$ 2.5 ns	50 pF	500 Ω	open

13. Application information
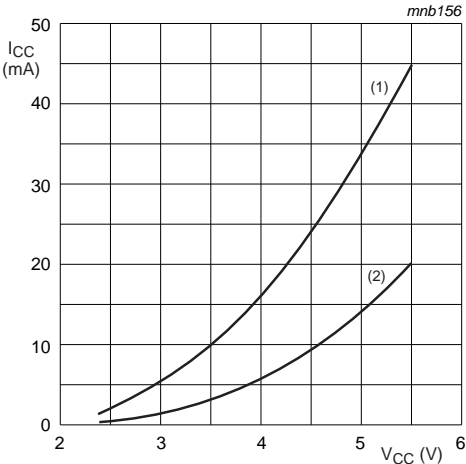
Linear change of V_I between 0.8 V to 2.0 V.

(1) Positive-going edge.

(2) Negative-going edge.

Fig 13. Average supply current as a function of supply voltage

14. Package outline

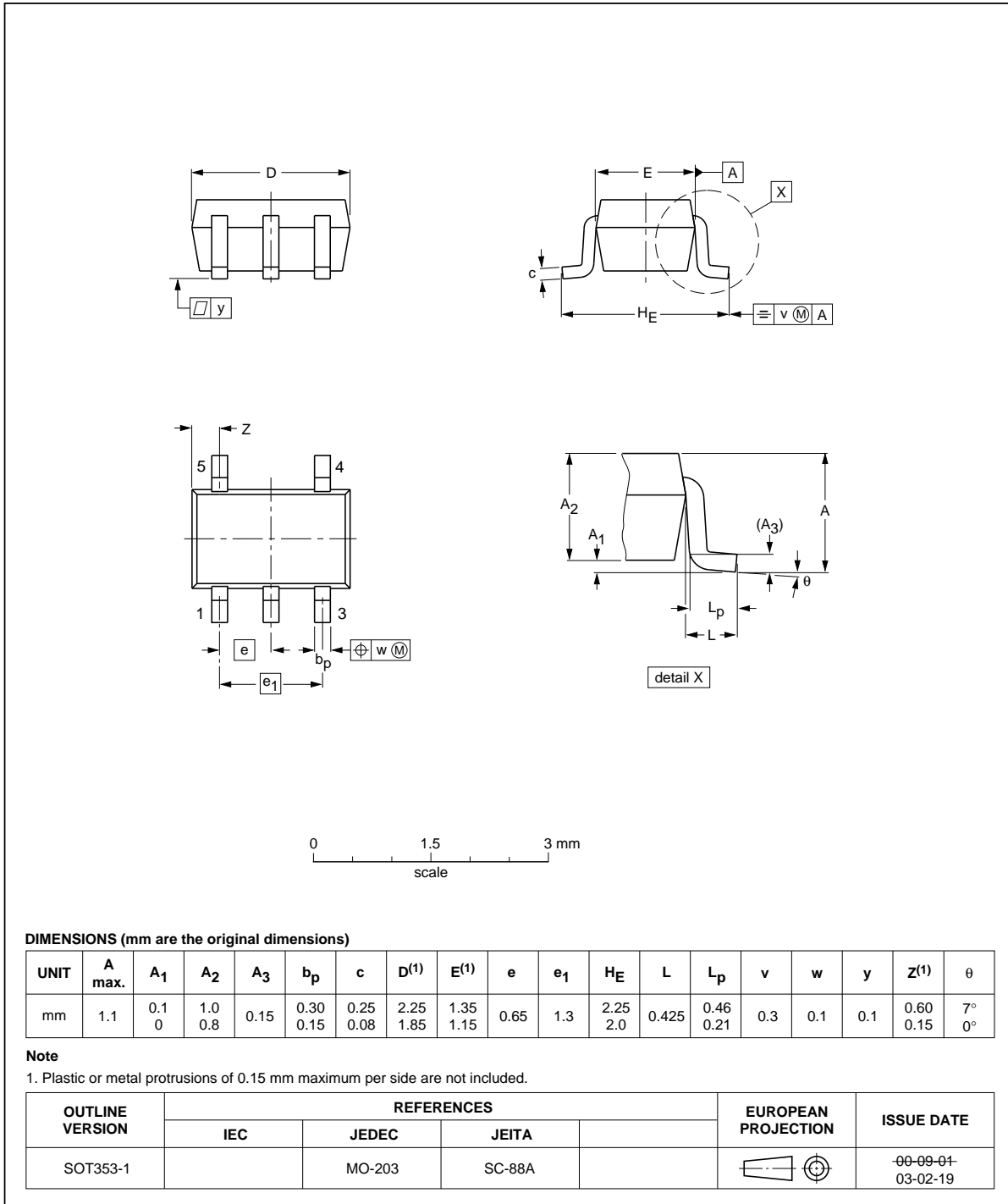**TSSOP5: plastic thin shrink small outline package; 5 leads; body width 1.25 mm**   **SOT353-1**

DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A1	A2	A3	bp	c	D(1)	E(1)	e	e1	HE	L	Lp	v	w	y	Z(1)	θ
mm	1.1	0.1 0	1.0 0.8	0.15	0.30 0.15	0.25 0.08	2.25 1.85	1.35 1.15	0.65	1.3	2.25 2.0	0.425	0.46 0.21	0.3	0.1	0.1	0.60 0.15	7° 0°

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT353-1		MO-203	SC-88A			~~00-09-01~~ 03-02-19

Fig 14.   Package outline SOT353-1 (TSSOP5)

Plastic surface-mounted package; 5 leads SOT753

DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1	b_p	c	D	E	e	H_E	L_p	Q	v	w	y
mm	1.1 0.9	0.100 0.013	0.40 0.25	0.26 0.10	3.1 2.7	1.7 1.3	0.95	3.0 2.5	0.6 0.2	0.33 0.23	0.2	0.2	0.1

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT753			SC-74A			02-04-16 06-03-16
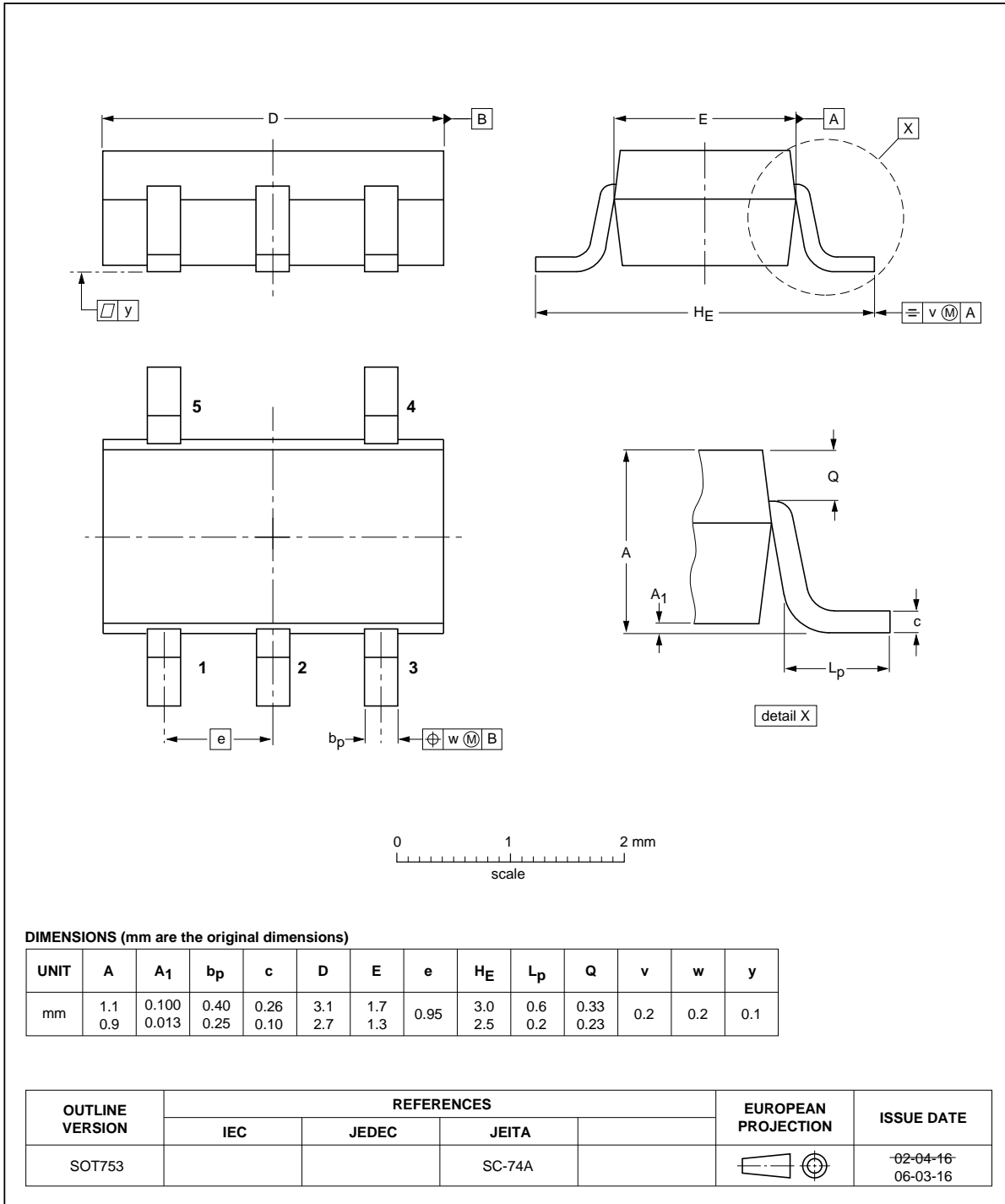
Fig 15. Package outline SOT753 (SC-74A)

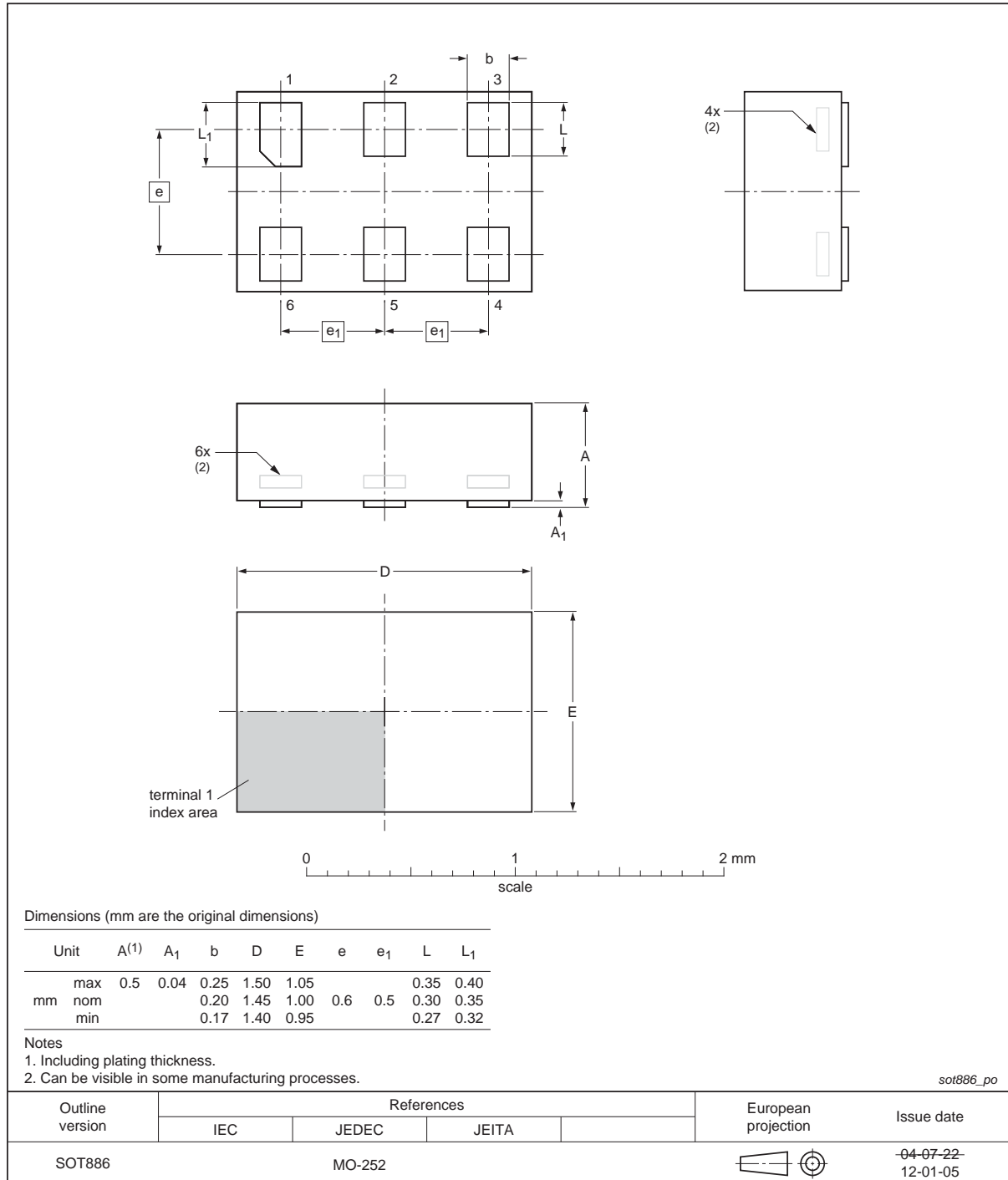XSON6: plastic extremely thin small outline package; no leads; 6 terminals; body 1 x 1.45 x 0.5 mm   SOT886

Dimensions (mm are the original dimensions)

Unit	A[1]	A₁	b	D	E	e	e₁	L	L₁
	max	0.5	0.04	0.25	1.50	1.05			0.35	0.40
mm nom			0.20	1.45	1.00	0.6	0.5	0.30	0.35
min			0.17	1.40	0.95			0.27	0.32

Notes
1. Including plating thickness.
2. Can be visible in some manufacturing processes.

Outline version	References				European projection	Issue date
	IEC	JEDEC	JEITA			
SOT886		MO-252				04-07-22 12-01-05

Fig 16.   Package outline SOT886 (XSON6)

XSON6: plastic extremely thin small outline package; no leads; 6 terminals; body 1 x 1 x 0.5 mm   SOT891
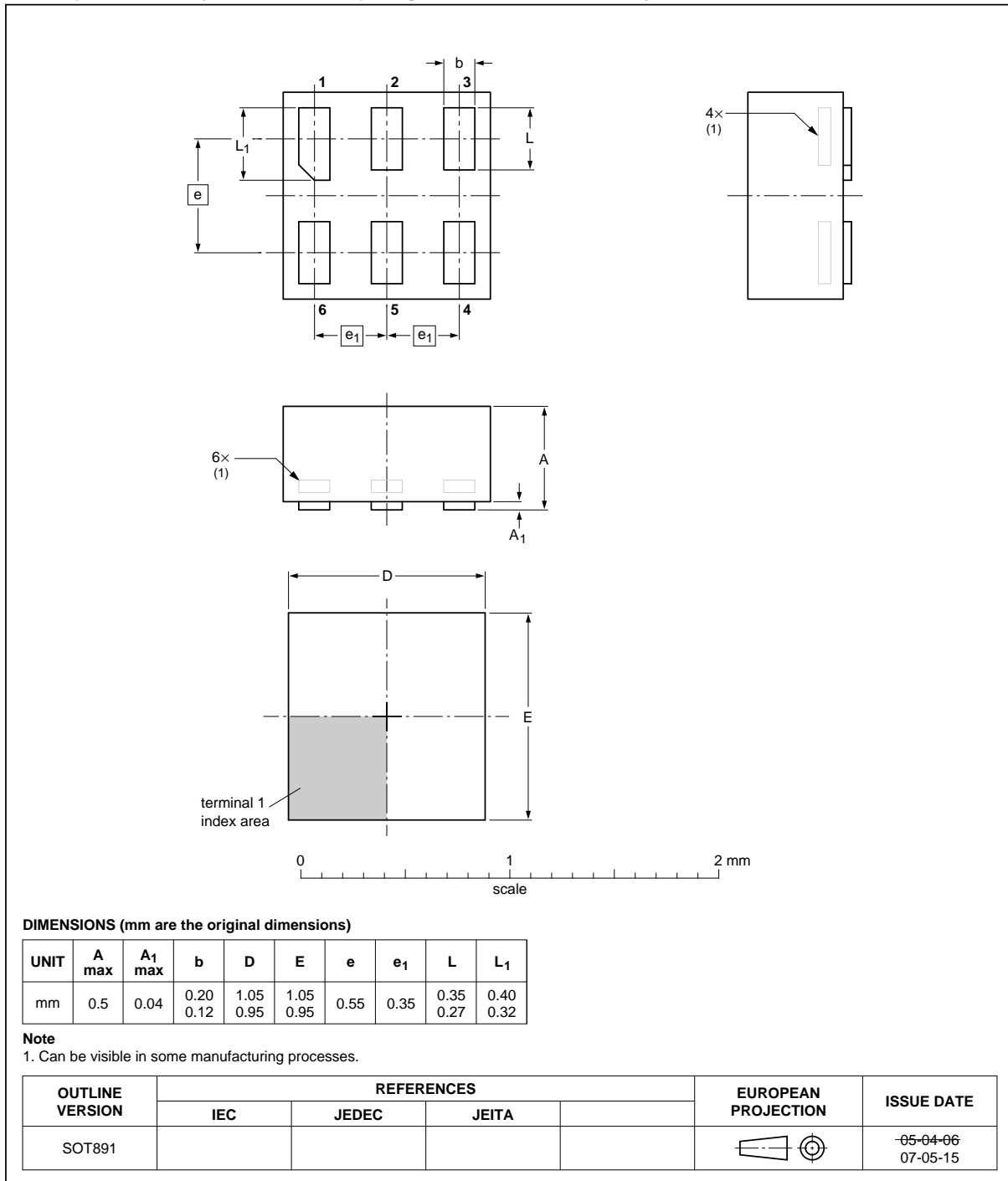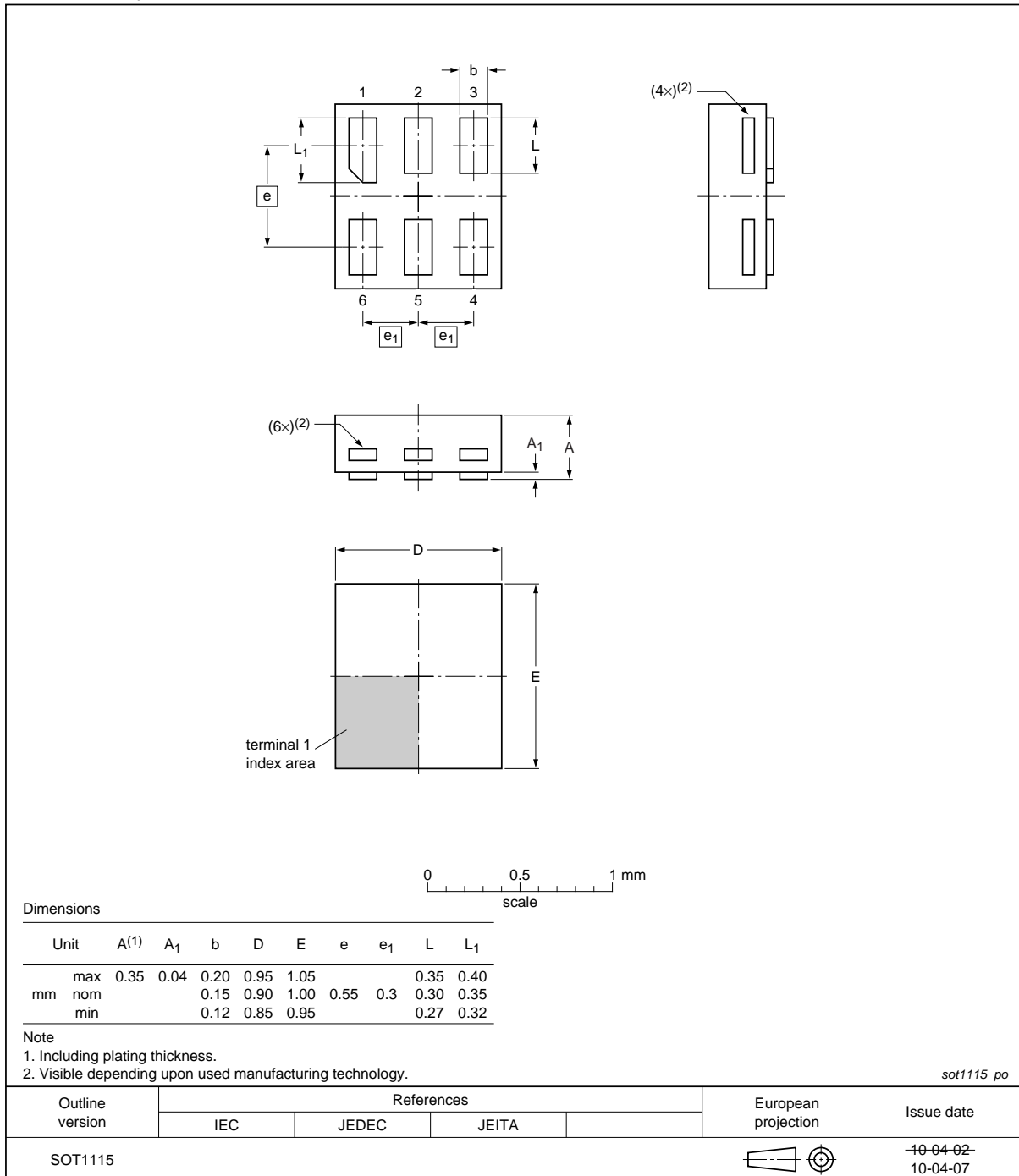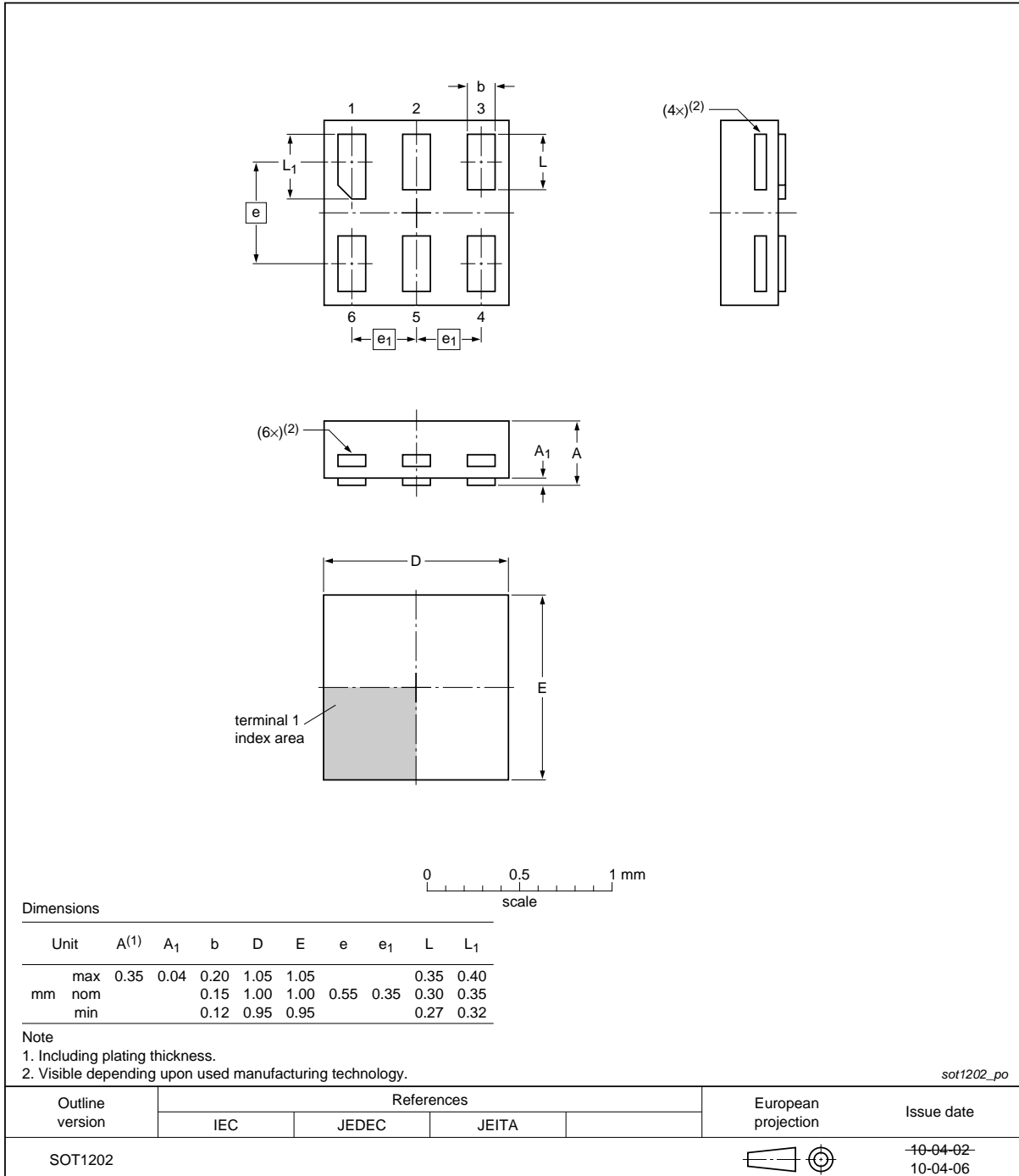
DIMENSIONS (mm are the original dimensions)

UNIT	A max	A$_1$ max	b	D	E	e	e$_1$	L	L$_1$
mm	0.5	0.04	0.20 0.12	1.05 0.95	1.05 0.95	0.55	0.35	0.35 0.27	0.40 0.32

Note

1. Can be visible in some manufacturing processes.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT891						~~05-04-06~~ 07-05-15

Fig 17. Package outline SOT891 (XSON6)

XSON6: extremely thin small outline package; no leads;
6 terminals; body 0.9 x 1.0 x 0.35 mm SOT1115

Dimensions

Unit		A[1]	A_1	b	D	E	e	e_1	L	L_1
mm	max	0.35	0.04	0.20	0.95	1.05			0.35	0.40
	nom			0.15	0.90	1.00	0.55	0.3	0.30	0.35
	min			0.12	0.85	0.95			0.27	0.32

Note
1. Including plating thickness.
2. Visible depending upon used manufacturing technology.

sot1115_po

Outline version	References				European projection	Issue date
	IEC	JEDEC	JEITA			
SOT1115						~~10-04-02~~ 10-04-07

Fig 18. Package outline SOT1115 (XSON6)

**XSON6: extremely thin small outline package; no leads;
6 terminals; body 1.0 x 1.0 x 0.35 mm**

SOT1202

Dimensions

Unit	A[1]	A_1	b	D	E	e	e_1	L	L_1
max	0.35	0.04	0.20	1.05	1.05			0.35	0.40
mm nom			0.15	1.00	1.00	0.55	0.35	0.30	0.35
min			0.12	0.95	0.95			0.27	0.32

Note
1. Including plating thickness.
2. Visible depending upon used manufacturing technology.

sot1202_po

Outline version	References				European projection	Issue date
	IEC	JEDEC	JEITA			
SOT1202						~~10-04-02~~ 10-04-06

Fig 19. Package outline SOT1202 (XSON6)

X2SON5: plastic thermal enhanced extremely thin small outline package; no leads;
5 terminals; body 0.8 x 0.8 x 0.35 mm   **SOT1226**

Dimensions

Unit	A[1]	A₁	A₃	D	Dₕ	E	b	e	k	L	v	w	y	y₁
mm max	0.35	0.04	0.128	0.85	0.30	0.85	0.27			0.27				
nom				0.80	0.25	0.80	0.22	0.48		0.22	0.1	0.05	0.05	0.05
min			0.040	0.75	0.20	0.75	0.17		0.20	0.17				

Note
1. Dimension A is including plating thickness.
2. Plastic or metal protrusions of 0.075 mm maximum per side are not included.

sot1226_po

Outline version	References				European projection	Issue date
	IEC	JEDEC	EIAJ			
SOT1226						~~12-04-10~~ 12-04-25

Fig 20. Package outline SOT1226 (X2SON5)

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15. Abbreviations

Table 12.   Abbreviations

Acronym	Description
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

16. Revision history

Table 13.   Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74LVC1G17 v.10	20120629	Product data sheet	-	74LVC1G17 v.9
Modifications:	• Added type number 74LVC1G17GX (SOT1226)			
	• Package outline drawing of SOT886 (Figure 16) modified.			
74LVC1G17 v.9	20111206	Product data sheet	-	74LVC1G17 v.8
Modifications:	• Legal pages updated.			
74LVC1G17 v.8	20110920	Product data sheet	-	74LVC1G17 v.7
74LVC1G17 v.7	20101110	Product data sheet	-	74LVC1G17 v.6
74LVC1G17 v.6	20070827	Product data sheet	-	74LVC1G17 v.5
74LVC1G17 v.5	20061006	Product data sheet	-	74LVC1G17 v.4
74LVC1G17 v.4	20041130	Product specification	-	74LVC1G17 v.3
74LVC1G17 v.3	20041018	Product specification	-	74LVC1G17 v.2
74LVC1G17 v.2	20040407	Product specification	-	74LVC1G17 v.1
74LVC1G17 v.1	20040324	Product specification	-	-

17. Legal information

17.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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